

N-Channel 30 V (D-S) MOSFET

PRODUCT SUMMARY						
V _{DS} (V)	$R_{DS(on)}\left(\Omega\right)$	I _D (A) ^a	Q _g (Typ.)			
30	0.007 at V _{GS} = 10 V	10	7.1			
30	0.009 at V _{GS} = 4.5 V	9	7.1			

FEATURES

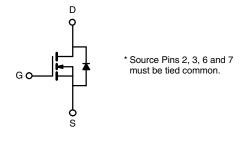
- TrenchFET® Power MOSFET
- 100 % R_g Tested
- 100 % UIS Tested
- Compliant to RoHS Directive 2002/95/EC



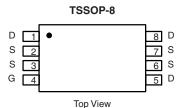
ROHS COMPLIANT

APPLICATIONS

- Notebook System Power
- Low Current DC/DC



N-Channel MOSFET



ABSOLUTE MAXIMUM RATINGS $(T_A =$	25 °C, unless other	erwise noted)		
Parameter		Symbol	Limit	Unit
Drain-Source Voltage		V_{DS}	30	V
Gate-Source Voltage		V_{GS}	± 20]
	T _C = 25 °C	I _D	10	
Continuous Drain Current (T _{.1} = 150 °C)	T _C = 70 °C		8.5	
Continuous Brain Curront (1j = 100 °C)	$T_A = 25 ^{\circ}C$		8.2	
	T _A = 70 °C		5.9 ^{b, c}	
Pulsed Drain Current		I _{DM}	30	Α
Source-Drain Current Diode Current	$T_C = 25 ^{\circ}C$	I _S 5.8		
Source Brain Guitern Blode Guitern	T _A = 25 °C	'5	1.8 ^{b, c}	
Pulsed Source-Drain Current		I _{SM}	30	
Single Pulse Avalanche Current	L = 0.1 mH	I _{AS}	10	
Single Pulse Avalanche Energy	L = 0.1 11111	E _{AS}	5	
	T _C = 25 °C		3.1	
Maximum Power Dissipation	T _C = 70 °C	P_D	2.0	w
Maximum Fower Dissipation	T _A = 25 °C	ם י	2.0 ^{b, c}]
	T _A = 70 °C		1.25 ^{b, c}	
Operating Junction and Storage Temperature Range		T _J , T _{stg}	- 55 to 150	°C

THERMAL RESISTANCE RAT	INGS				
Parameter		Symbol	Тур.	Max.	Unit
Maximum Junction-to-Ambient ^{b, d}	t ≤ 10 s	R _{thJA}	52	62.5	°C/W
Maximum Junction-to-Foot (Drain)	Steady-State	$R_{th,JF}$	30	40	0/11

Notes:

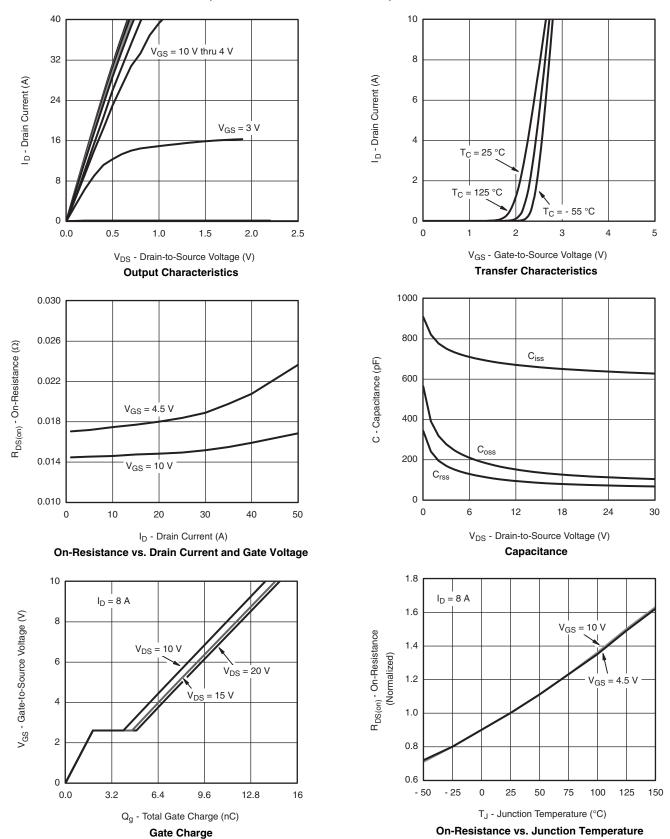
- a. Based on T_C = 25 °C.
- b. Surface mounted on 1" x 1" FR4 board.
- c. t = 10 s.
- d. Maximum under steady state conditions is 110 °C/W.



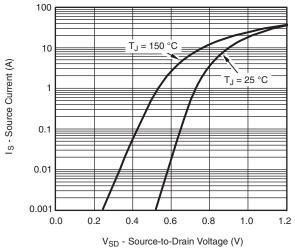
Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit	
Static	•	,					
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$	30			V	
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	I _D = 250 μA		3.0		\//0C	
V _{GS(th)} Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	I _D = 250 μA		- 5.2		mV/°C	
Gate Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	1.2		2.5	V	
Gate-Body Leakage	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$			100	nA	
7 0		V _{DS} = 30 V, V _{GS} = 0 V			1	—	
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = 30 V, V _{GS} = 0 V, TJ = 55 °C			10	μΑ	
On -State Drain Current ^b	I _{D(on)}	V _{DS} = 5 V, V _{GS} = 10 V	30			Α	
h	_	V _{GS} = 10 V, I _D = 8 A		0.007		†	
Drain-Source On-State Resistance ^b	R _{DS(on)}	V _{GS} = 4.5 V, I _D = 5 A		0.009		Ω	
Forward Transconductance ^b	9 _{fs}	V _{DS} = 15 V, I _D = 8 A		27		S	
Dynamic ^a	l	<u> </u>					
Input Capacitance	C _{iss}			1060			
Output Capacitance	C _{oss}	V _{DS} = 15 V, V _{GS} = 0 V, I _D = 1 MHz		140		pF	
Reverse Transfer Capacitance	C _{rss}			86		•	
Total Gate Charge		$V_{DS} = 15 \text{ V}, V_{GS} = 10 \text{ V}, I_{D} = 8 \text{ A}$		14.5	22		
	Q_g			7.1	11	-	
Gate-Source Charge	Q _{gs}	$V_{DS} = 15 \text{ V}, V_{GS} = 4.5 \text{ V}, I_{D} = 8 \text{ A}$		1.9		nC	
Gate-Drain Charge	Q_{gd}	1		2.7			
Gate Resistance	R_{g}	f = 1 MHz	0.5	2.6	5.2	Ω	
Turn-On Delay Time	t _{d(on)}			14	28		
Rise Time	t _r	$V_{DD} = 15 \text{ V}, R_{L} = 3 \Omega$		45	80		
Turn-Off Delay Time	t _{d(off)}	$I_D \cong 5 \text{ A}, V_{GEN} = 4.5 \text{ V}, R_g = 1 \Omega$		18	35		
Fall Time	t _f]		12	24		
Turn-On Delay Time	t _{d(on)}			7	14	ns	
Rise Time	t _r	$V_{DD} = 15 \text{ V}, R_{L} = 3 \Omega$		10	20		
Turn-Off Delay Time	t _{d(off)}	$I_D \cong 5 \text{ A}, V_{GEN} = 10 \text{ V}, R_g = 1 \Omega$		15	30		
Fall Time	t _f	1		7	14		
Drain-Source Body Diode Characterist	cs						
Continuous Source-Drain Diode Current	I _S	T _C = 25 °C			10	۸	
Pulse Diode Forward Current ^a	I _{SM}				30	A	
Body Diode Voltage	V_{SD}	I _S = 2 A		0.77	1.1	V	
Body Diode Reverse Recovery Time	t _{rr}			17	34	ns	
Body Diode Reverse Recovery Charge	Q _{rr}] EA di/dt 100 A/:- T 05 00		9	18	nC	
Reverse Recovery Fall Time	t _a	$I_F = 5 \text{ A}, \text{ dI/dt} = 100 \text{ A/}\mu\text{s}, T_J = 25 ^{\circ}\text{C}$		10		_	
Reverse Recovery Rise Time	t _b			7		nS	

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

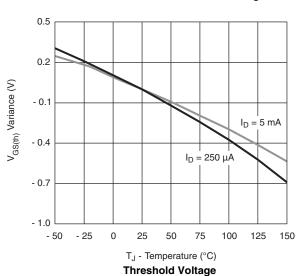






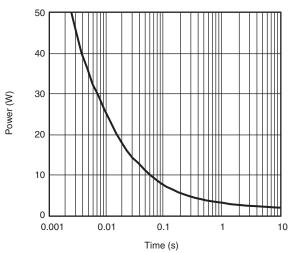


Source-Drain Diode Forward Voltage

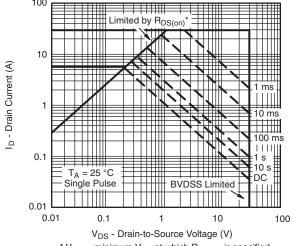


 $C_{\text{O}} = 8 \text{ A}$ C_{O

On-Resistance vs. Gate-to-Source Voltage



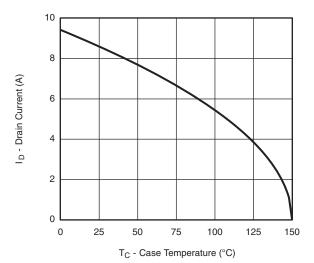
Single Pulse Power, Junction-to-Ambient



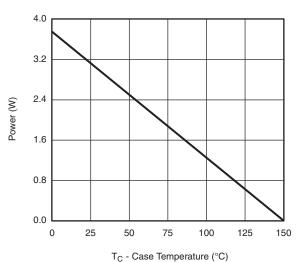
* V_{GS} > minimum V_{GS} at which R_{DS(on)} is specified

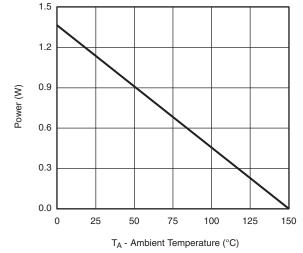
Safe Operating Area, Junction-to-Ambient





Current Derating*



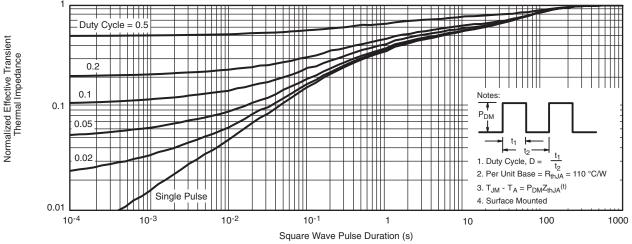


Power Derating, Junction-to-Foot

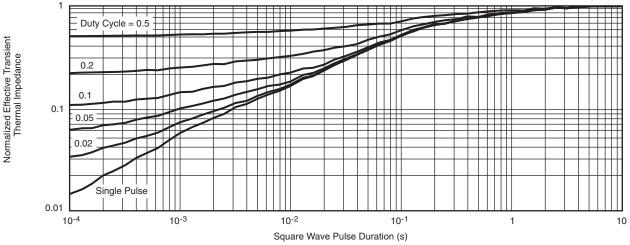
Power Derating, Junction-to-Ambient

^{*} The power dissipation P_D is based on $T_{J(max)} = 150$ °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.





Normalized Thermal Transient Impedance, Junction-to-Ambient

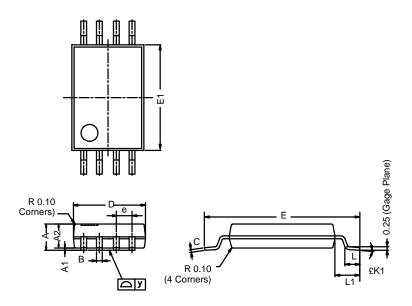


Normalized Thermal Transient Impedance, Junction-to-Foot



TSSOP: 8-LEAD

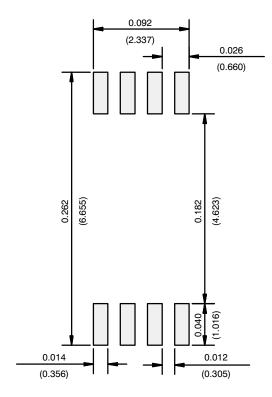
JEDEC Part Number: MO-153



	MILLIMETERS				
Dim	Min	Nom	Max		
Α	-	_	1.20		
A ₁	0.05	0.10	0.15		
A ₂	0.80	1.00	1.05		
В	0.19	0.28	0.30		
С	-	0.127	-		
D	2.90	3.00	3.10		
Е	6.20	6.40	6.60		
E ₁	4.30	4.40	4.50		
е	_	0.65	-		
L	0.45	0.60	0.75		
L ₁	0.90	1.00	1.10		
Υ	-	-	0.10		
£ K1	0°	3°	6°		
ECN: S-03 DWG: 584	946—Rev. G, 0	9-Jul-01			



RECOMMENDED MINIMUM PADS FOR TSSOP-8



Recommended Minimum Pads Dimensions in Inches/(mm)



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